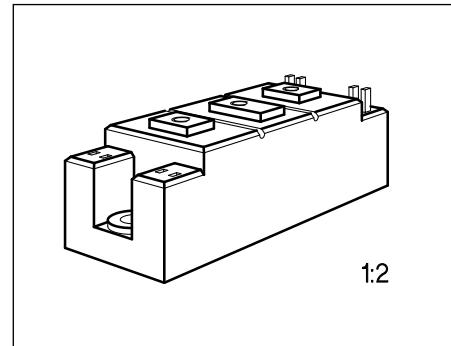


$V_{DS} = 500 \text{ V}$   
 $I_D = 2 \times 35 \text{ A}$   
 $R_{DS(on)} = 0.17 \Omega$

- Power module
- Half-bridge
- FREDFET
- N channel
- Enhancement mode
- Package with insulated metal base plate
- Package outline/Circuit diagram: 2a<sup>1)</sup>



Type	Ordering Code
BSM 254 F	C67076-A1150-A2

### Maximum Ratings

Parameter	Symbol	Values	Unit
Drain-source voltage	$V_{DS}$	500	V
Drain-gate voltage, $R_{GS} = 20 \text{ k}\Omega$	$V_{DGR}$	500	
Gate-source voltage	$V_{GS}$	$\pm 20$	
Continuous drain current, $T_C = 25 \text{ }^\circ\text{C}$	$I_D$	35	A
Pulsed drain current, $T_C = 25 \text{ }^\circ\text{C}$	$I_{D \text{ puls}}$	140	
Operating and storage temperature range	$T_j, T_{stg}$	-55 ... +150	°C
Power dissipation, $T_C = 25 \text{ }^\circ\text{C}$	$P_{tot}$	400	W
Thermal resistance			K/W
Chip-case	$R_{th JC}$	$\leq 0.31$	
Insulation test voltage <sup>2)</sup> , $t = 1 \text{ min.}$	$V_{is}$	2500	V <sub>ac</sub>
Creepage distance, drain-source	-	16	mm
Clearance, drain-source	-	11	
DIN humidity category, DIN 40 040	-	F	-
IEC climatic category, DIN IEC 68-1	-	55/150/56	

<sup>1)</sup> See chapter Package Outline and Circuit Diagrams.

<sup>2)</sup> Insulation test voltage between drain and base plate referred to standard climate 23/50 in acc. with DIN 50 014, IEC 146, para. 492.1.

**Electrical Characteristics**at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

**Static Characteristics**

Drain-source breakdown voltage $V_{GS} = 0, I_D = 0.25 \text{ mA}$	$V_{(BR)DSS}$	500	—	—	V
Gate threshold voltage $V_{GS} = V_{DS}, I_D = 1 \text{ mA}$	$V_{GS(\text{th})}$	2.1	3.0	4.0	
Zero gate voltage drain current $V_{DS} = 500 \text{ V}, V_{GS} = 0$ $T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	$I_{DSS}$	—	50	250	$\mu\text{A}$
—	—	—	300	1000	
Gate-source leakage current $V_{GS} = 20 \text{ V}, V_{DS} = 0$	$I_{GSS}$	—	10	100	nA
Drain-source on-state resistance $V_{GS} = 10 \text{ V}, I_D = 22 \text{ A}$	$R_{DS(\text{on})}$	—	0.14	0.17	$\Omega$

**Dynamic Characteristics**

Forward transconductance $V_{DS} \geq 2 \times I_D \times R_{DS(\text{on})\text{max}}, I_D = 22 \text{ A}$	$g_{fs}$	13	20	—	S
Input capacitance $V_{GS} = 0, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{iss}$	—	18	24	nF
Output capacitance $V_{GS} = 0, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{oss}$	—	1.3	1.9	
Reverse transfer capacitance $V_{GS} = 0, V_{DS} = 25 \text{ V}, f = 1 \text{ MHz}$	$C_{rss}$	—	0.48	0.7	
Turn-on time $t_{on}$ ( $t_{on} = t_{d(on)} + t_r$ ) $V_{CC} = 250 \text{ V}, V_{GS} = 10 \text{ V}$ $I_D = 22 \text{ A}, R_{GS} = 3.3 \Omega$	$t_{d(on)}$	—	40	—	ns
	$t_r$	—	30	—	
Turn-off time $t_{off}$ ( $t_{off} = t_{d(off)} + t_f$ ) $V_{CC} = 250 \text{ V}, V_{GS} = 10 \text{ V}$ $I_D = 22 \text{ A}, R_{GS} = 3.3 \Omega$	$t_{d(off)}$	—	70	—	
	$t_f$	—	55	—	

**Electrical Characteristics (cont'd)**at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.

Parameter	Symbol	Values			Unit
		min.	typ.	max.	

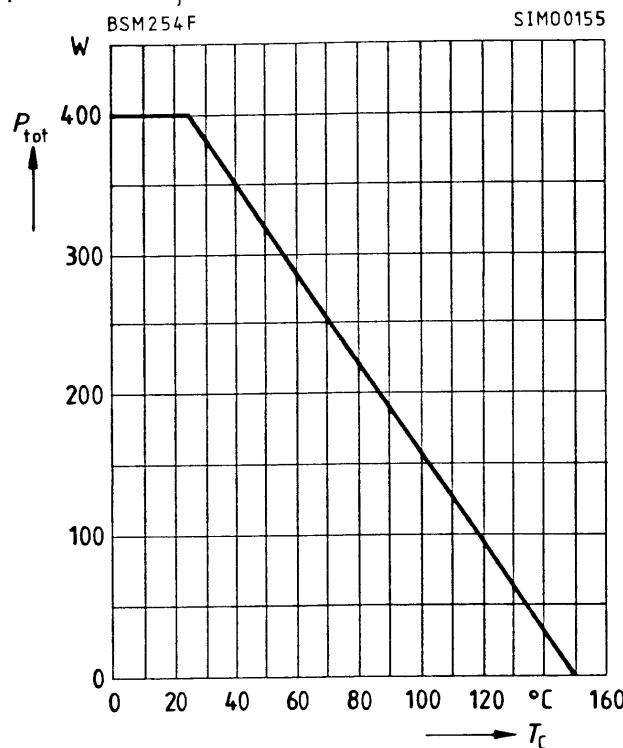
**Fast-recovery reverse diode**

Continuous reverse drain current $T_C = 25^\circ\text{C}$	$I_S$	—	—	35	A
Pulsed reverse drain current $T_C = 25^\circ\text{C}$	$I_{SM}$	—	—	140	
Diode forward on-voltage $I_F = 70\text{ A}$ , $V_{GS} = 0$	$V_{SD}$	—	1.2	1.6	V
Reverse recovery time $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$ , $V_R = 100\text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	$t_{rr}$	—	200	280	ns
Reverse recovery charge $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$ , $V_R = 100\text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	$Q_{rr}$	—	1.5	2.5	$\mu\text{C}$
Repetitive peak reverse current $I_F = I_S$ , $di_F/dt = 100\text{ A}/\mu\text{s}$ , $V_R = 100\text{ V}$ $T_j = 25^\circ\text{C}$ $T_j = 150^\circ\text{C}$	$I_{RRM}$	—	12	—	A
		—	28	—	

**Characteristics at  $T_j = 25^\circ\text{C}$ , unless otherwise specified.**

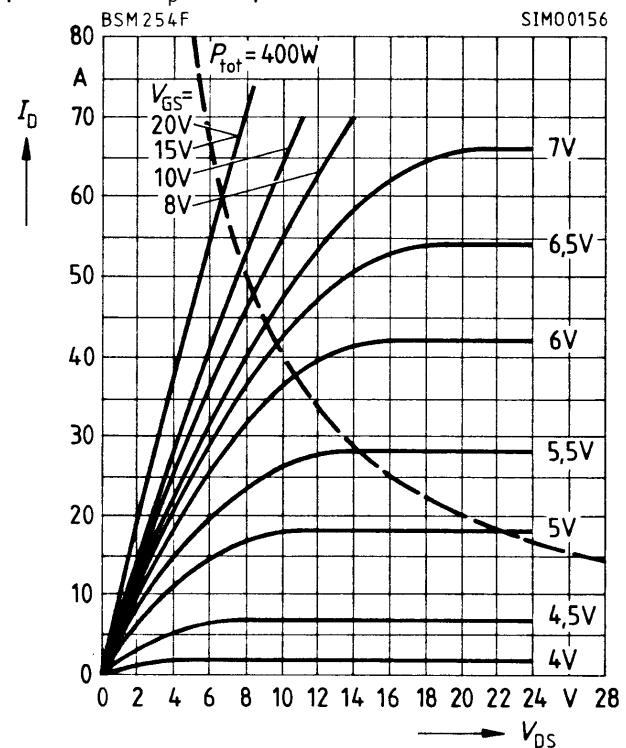
**Power dissipation  $P_{\text{tot}} = f(T_C)$**

parameter:  $T_j = 150^\circ\text{C}$



**Typ. output characteristics  $I_D = f(V_{DS})$**

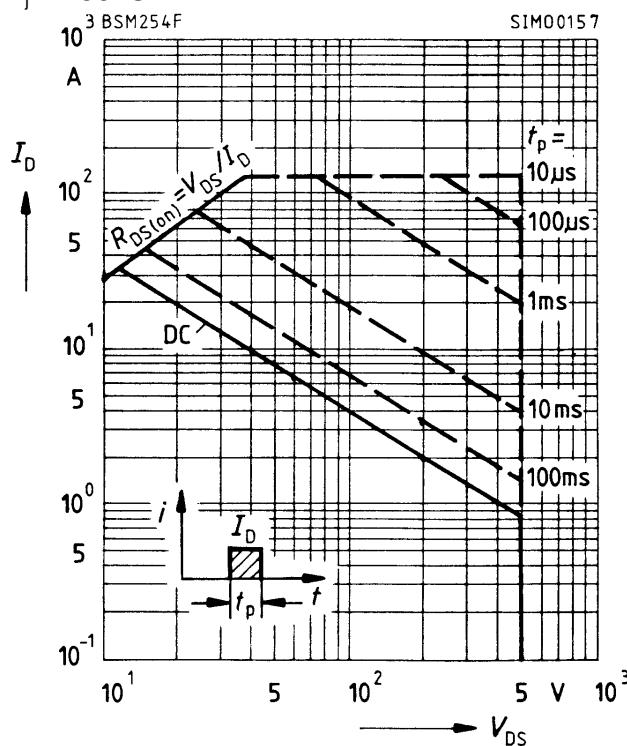
parameter:  $t_p = 80 \mu\text{s}$



**Safe operating area  $I_D = f(V_{DS})$**

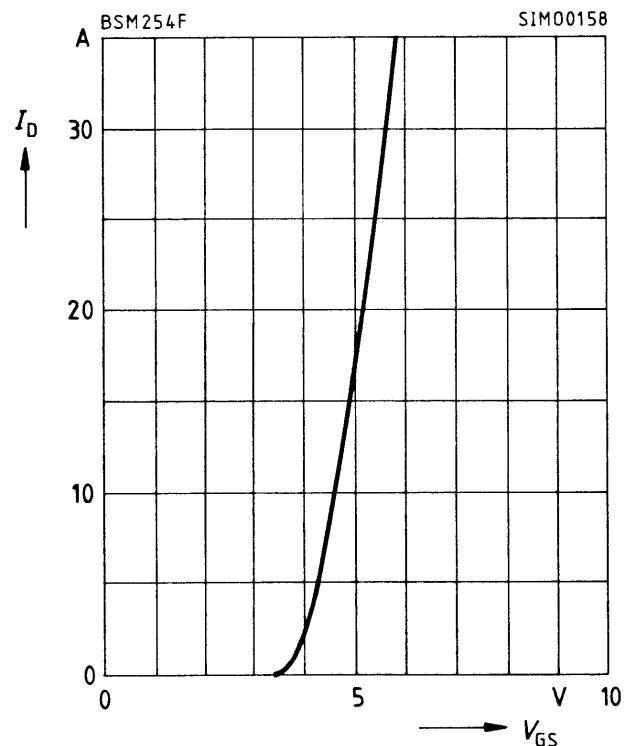
parameter: single pulse,  $T_C = 25^\circ\text{C}$

$T_j \leq 150^\circ\text{C}$

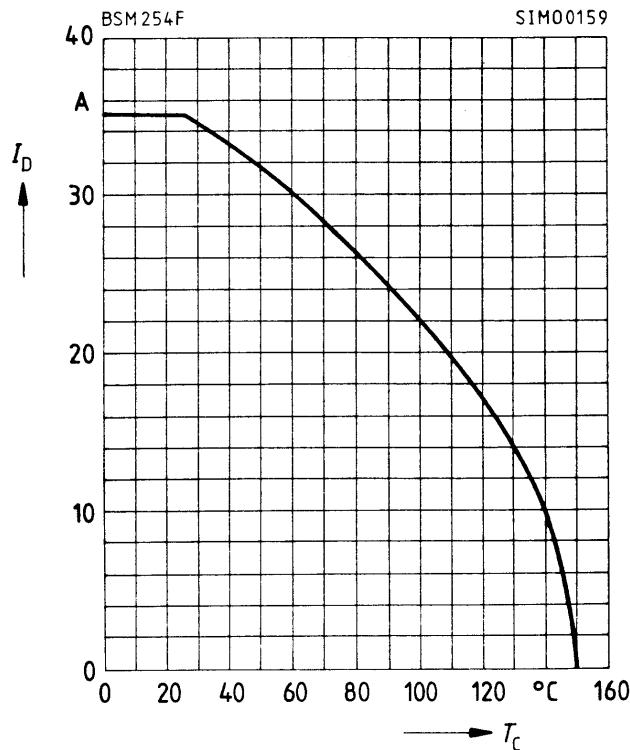


**Typ. transfer characteristic  $I_D = f(V_{GS})$**

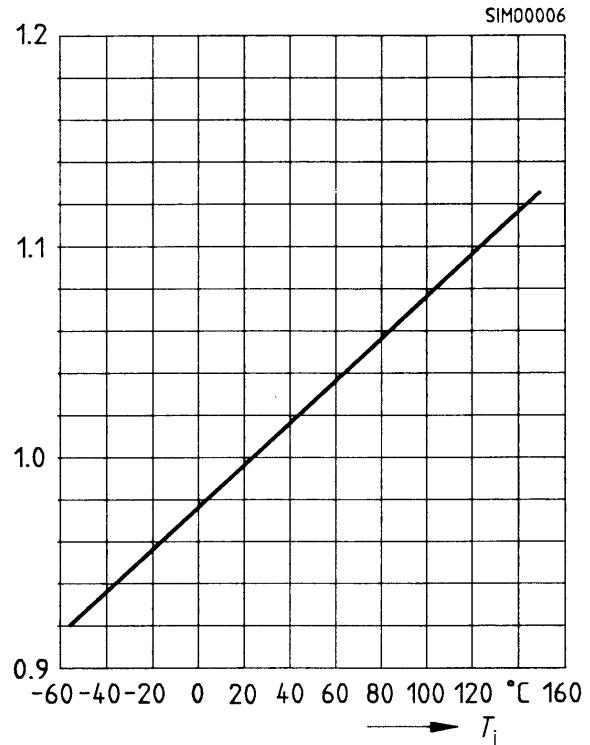
parameter:  $t_p = 80 \mu\text{s}$ ,  $V_{DS} = 25 \text{ V}$



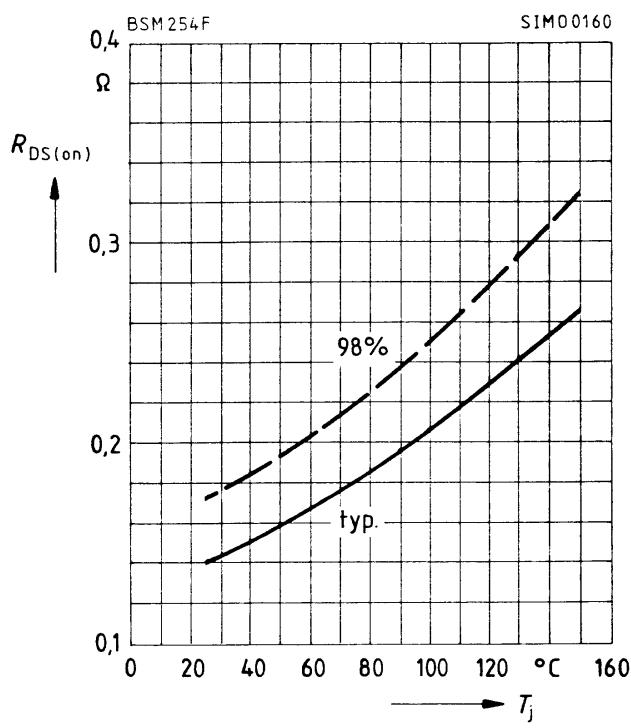
**Drain current  $I_D = f(T_C)$**   
parameter:  $V_{GS} \geq 10$  V,  $T_j = 150$  °C



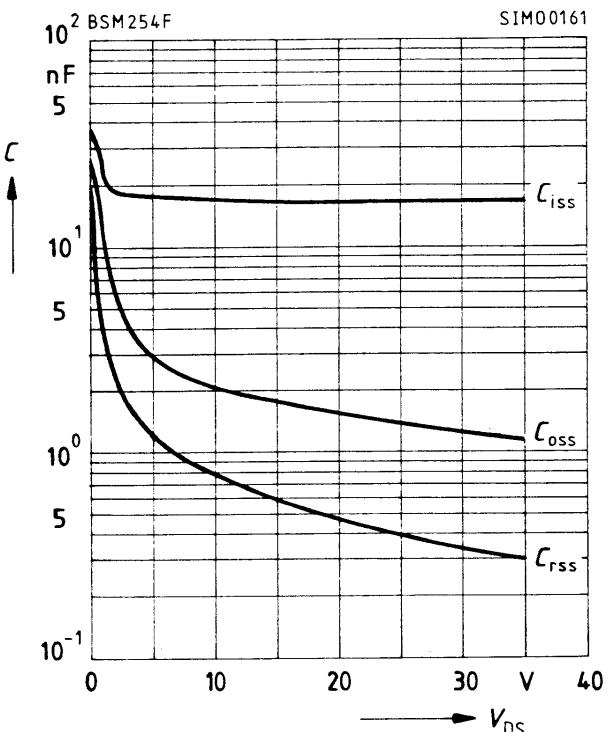
**Drain-source breakdown voltage  
 $V_{(BR)DSS}(T_j) = b \times V_{(BR)DSS}(25^\circ\text{C})$**

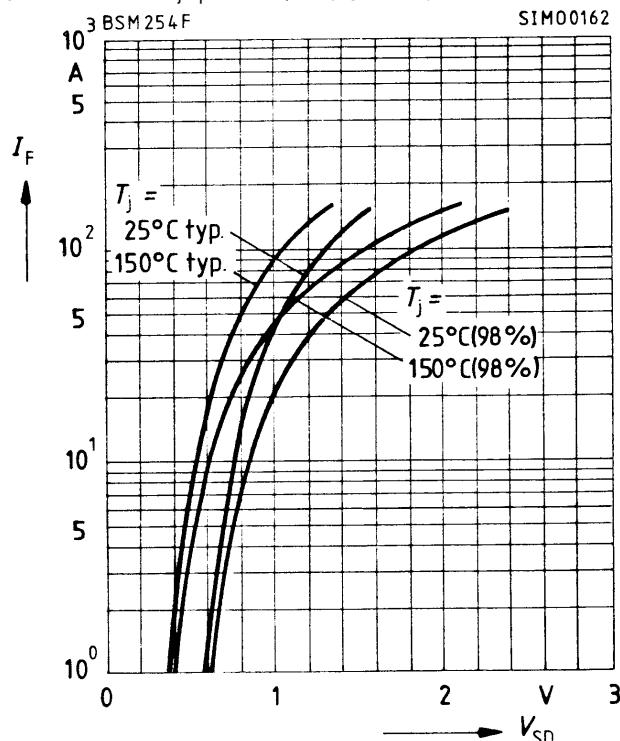
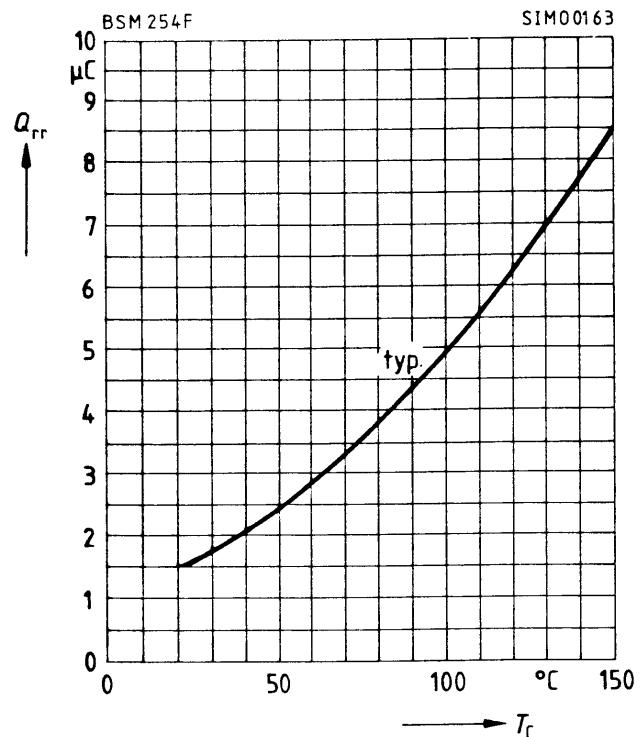


**Drain source on-state resistance**  
 $R_{DS(on)} = f(T_j)$   
parameter:  $I_D = 22$  A;  $V_{GS} = 10$  V, (spread)

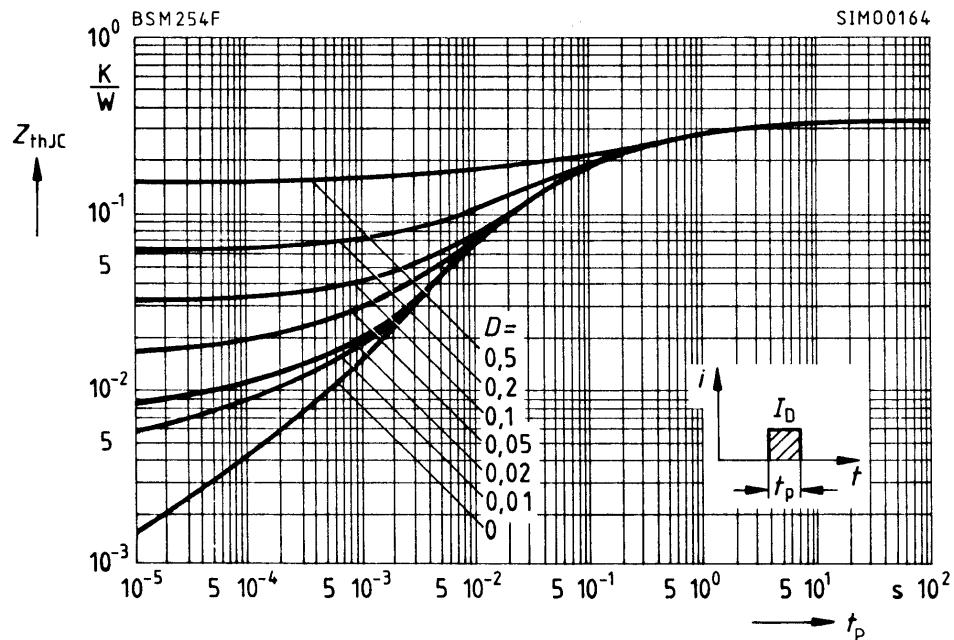


**Typ. capacitances  $C = f(V_{DS})$**   
parameter:  $V_{GS} = 0$ ,  $f = 1$  MHz (spread)



**Forward characteristics****of fast-recovery reverse diode**  $I_F = f(V_{SD})$ parameter:  $T_p t_p = 80 \mu\text{s}$  (spread)**Typ. reverse recovery charge**  $Q_{rr} = f(T_j)$ parameter:  $di/dt = 100 \text{ A}/\mu\text{s}$ ,  $I_F = 35 \text{ A}$  $V_R = 100 \text{ V}$ 

**Transient thermal impedance**  $Z_{\text{thJC}} = f(t_p)$   
 parameter:  $D = t_p/T$



**Typ. gate charge**  $V_{\text{GS}} = f(Q_{\text{Gate}})$   
 parameter:  $I_{\text{Dpuls}} = 52.5 \text{ A}$

